Se	arch	rch Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/812,477	WANG ET AL.	
Examiner	Art Unit	_
Frank Duong	2616	

SEARCHED				
Class	Subclass	Date	Examiner	
<u> </u>				

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
Interference Search (see printout)		3/16/2006	FD

SEARCH N (INCLUDING SEARC		")
	DATE	EXMR
EAST Search (see printout)	3/16/2006	FD
Inventorship Search	3/16/2006	FD
IEEE/Internet Search	3/16/2006	FD